

Search Notes

Application/Control No.

10/693,135

Examiner

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Applicant(s)/Patent under
Reexamination

CHEN, ERNEST C.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	265	1/5/2006	EB
375	295	1/5/2006	EB
375	299	1/5/2006	EB
375	316	1/5/2006	EB
375	340	1/5/2006	EB
375	349	1/5/2006	EB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	1/5/2006	EB